

Notice of References Cited	Application/Control No. 10/621,596	Applicant(s)/Patent Under Reexamination SHON LOW ET AL.	
	Examiner DUC Q. DINH	Art Unit 2674	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-6,954,184	10-2005	Kurashima et al.	345/1.3
*	C	US-5,896,116	04-1999	Torizuka et al.	345/87
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	K	US-			
	L	US-			
	M	US-			

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NON-PATENT DOCUMENTS

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